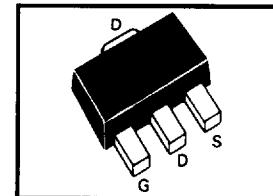


SOT89 N CHANNEL ENHANCEMENT MODE VERTICAL DMOS FET

ZVN4206Z

PARTMARKING DETAIL – ZVN4206Z – N26

- * FOR TYPICAL CHARACTERISTIC GRAPHS SEE
ZVN4206G DATASHEET



ABSOLUTE MAXIMUM RATINGS

PARAMETER	SYMBOL	VALUE	UNIT
Drain-Source Voltage	V _{DS}	60	V
Continuous Drain Current @ Tamb=25°C	I _D	0.9	A
Pulsed Drain Current	I _{DM}	8	A
Gate-Source Voltage	V _{GS}	± 20	V
Max Power Dissipation @ Tamb=25°C	P _{TOT}	1.5	W
Operating And Storage Temperature Range	t _{j:tstg}	-55 TO +150	°C

ELECTRICAL CHARACTERISTICS (at Tamb=25°C unless otherwise stated)

PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	CONDITIONS.
Drain-Source Breakdown Voltage	B _{VDSS}	60			V	I _D =1mA, V _{GS} =0
Gate-Source Threshold Voltage	V _{GS(TH)}	1.3		3	V	I _D =1mA, V _{DS} =V _{GS}
Gate Body Leakage	I _{GSS}			100	nA	V _{GS} =±20V, V _{DS} =0
Zero Gate Voltage Drain Current (2)	I _{DSS}			10 100	μA μA	V _{DS} =max rating, V _{GS} =0 V _{DS} =0.8xmax.rating, V _{GS} =0 (T=125°C)
On-State Drain Current *	I _{D(ON)}	3			mA	V _{DS} =25V, V _{GS} =10V
Static Drain-Source On-State Resistance *	R _{D(S)} (ON)			1 1.5	Ω Ω	I _D =1.5A, V _{GS} =10V I _D =0.5A, V _{GS} =5V
Forward Transconductance (2)	G _F	0.3			S	V _{DS} =25V, I _D =250mA
Input Capacitance (2)	C _{ISS}			100	pF	V _{DS} =25V,
Common Source Output Capacitance (2)	C _{OSS}			60	pF	V _{GS} =0
Reverse Transfer Capacitance (2)	C _{rss}			20	pF	f=1MHz
Turn-On Delay Time (1) (2)	T _{D(ON)}			8	ns	V _{DD} =25V, I _D =250mA
Rise Times (1) (2)	T _R			12	ns	
Turn-Off Delay Time (1) (2)	T _{D(OFF)}			12	ns	
Fall Time (1) (2)	T _F			15	ns	

DRAIN-SOURCE DIODE CHARACTERISTICS

PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	CONDITIONS.
Forward on voltage *	V _{SD}		0.85		V	V _{GS} =0, I _S =-0.6A
Reverse Recovery Time	T _{RR}		70		ns	V _{GS} =0, I _F =-0.6 I _R =0.1A

(1) Switching times measured with 50Ω source impedance and <5ns rise time on a pulse generator.

(2) Sample test.

(3) Measured under pulsed conditions. Pulse width=300μs. Duty cycles 2%.